

# 10-27GHz Bidirectionnal Detector

*Preliminary*

## GaAs Monolithic Microwave IC

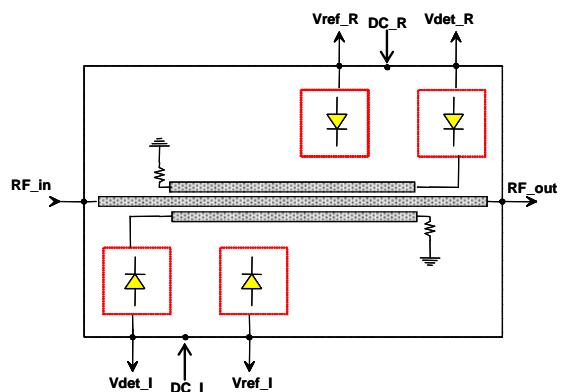
### Description

The CHE1260 is a bidirectionnal detector that integrates a passive bidirectionnal coupler, two matched detection diodes and two reference diodes.

It allows the measurement of transmitted and reflected power. It is designed for a wide range of applications where an accurate transmitted power control is required, typically commercial communication systems.

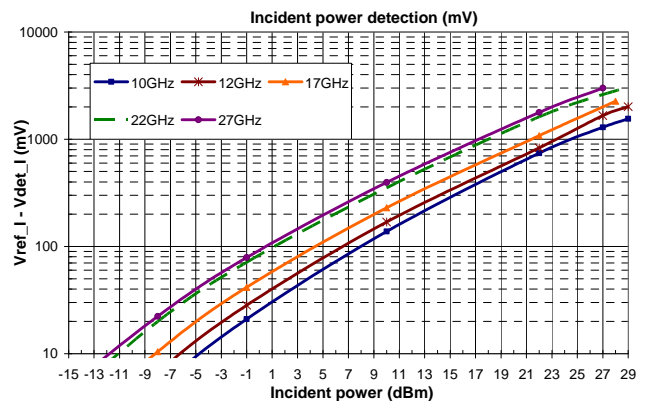
The circuit is manufactured with a Schottky diode MMIC process, 1µm gate length, via holes through the substrate and air bridges.

It is available in chip form.



### Main Features

- Wide frequency range 10-27GHz
- Bidirectionnal detection
- 30dB dynamic range
- ESD protected
- Chip size: 1.41 x 1.41 x 0.1 mm
- BCB layer protection (see page 8)



### Main Characteristics

Tamb = +25°C, VDC = +4.5V (on DC\_I and DC\_R)

Symbol	Parameter	Min	Typ	Max	Unit
F	Frequency range	10		27	GHz
IL	Insertion Loss		0.8		dB
Dr	Dynamic Range		30		dB

ESD Protection: Electrostatic discharge sensitive device. Observe handling precautions!

## Electrical Characteristics

Preliminary

Tamb = +25°C, VDC = +4.5V (on DC\_I and DC\_R)

Symbol	Parameter	Min	Typ	Max	Unit
F	Frequency range	10		27	GHz
IL	Insertion Loss		0.8		dB
Cd	Coupler Directivity		13		dB
Dr	Dynamic Range		30		dB
Pr	Power Range: 10 - 17GHz 17 - 21GHz 21 - 24GHz 24 - 27GHz (for transmitted and/or reflected power)	-1 -3 -6 -8			dBm
Vdetect_I	Voltage detection from transmitted power Vref_I – Vdet_I From Pr_min to Pr_max		20 to 2500		mV
Vdetect_R	Voltage detection from reflected power Vref_R – Vdet_R From Pr_min to Pr_max		20 to 2500		mV
RLin	Input return loss		-11		dB
RLout	Output return loss		-11		dB
VDC	Bias Voltage		4.5		V
IDC	Bias Current (on ports DC_I or DC_R)		33		μA

These values are representative of on-wafer measurements that are made without bonding wires at the RF ports but with 100kΩ resistor in parallel on pads Vdet\_I, Vref\_I, Vdet\_R and Vref\_R (see notes, page 8).

## Absolute Maximum Ratings (1)

Tamb = +25°C

Symbol	Parameter	Values	Unit
VDC	Bias voltage (on ports DC_I and DC_R)	6	V
Top	Operating temperature range	-40 to +85	°C
Tstg	Storage temperature range	-55 to +125	°C
P_max	Maximum power (for transmitted and/or reflected power)	30	dBm

(1) Operation of this device above any of these parameters may cause permanent damage.

## Typical on-wafer Sij parameters

*Preliminary*

Tamb = +25°C, Vdc = +4.5V (on DC\_I and DC\_R), 100k Ω resistor in parallel on pads Vdet\_I, Vref\_I, Vdet\_R and Vref\_R (see notes, page 8).

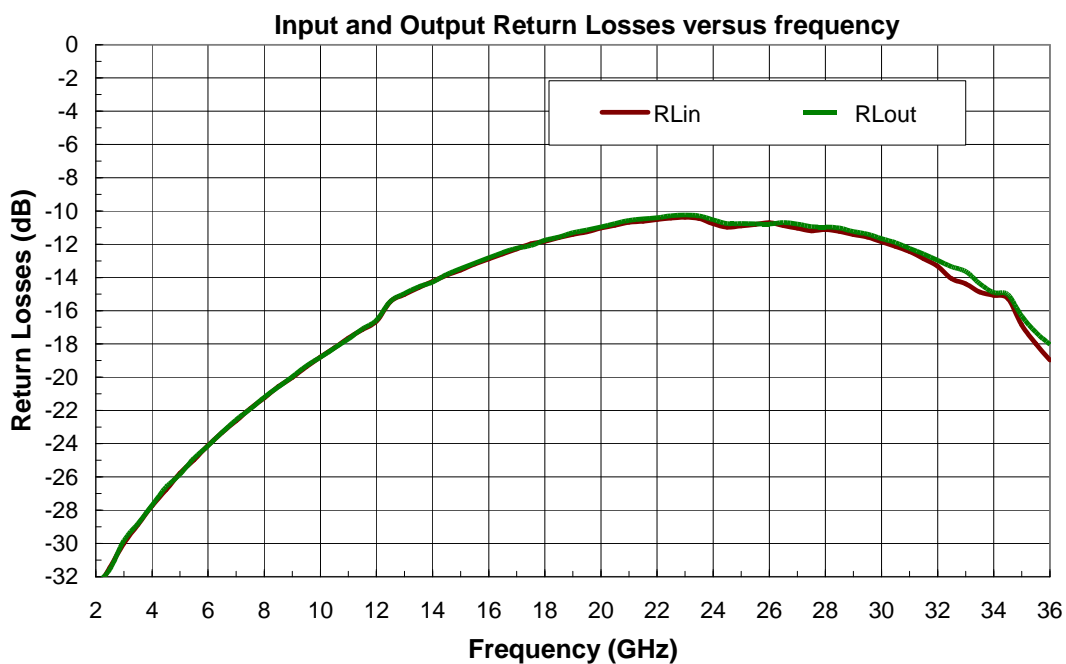
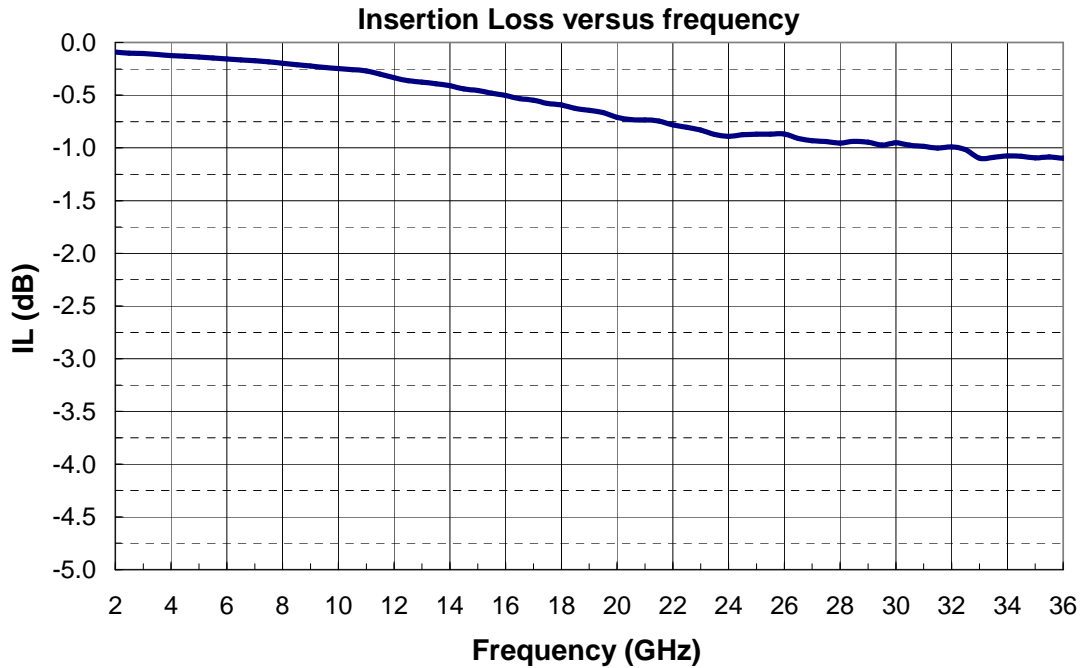
Freq (GHz)	dB(S11)	Ph(S11) (°)	dB(S12)	Ph(S12) (°)	dB(S2 1)	Ph(S21) (°)	dB(S22)	Ph(S22) (°)
2	-32.9	54	-0.1	-13	-0.1	-13	-32.5	53
3	-30.0	52	-0.1	-20	-0.1	-20	-29.8	50
4	-27.7	50	-0.1	-27	-0.1	-27	-27.7	49
5	-25.8	47	-0.1	-33	-0.1	-33	-25.9	45
6	-24.1	42	-0.2	-40	-0.2	-40	-24.1	40
7	-22.6	36	-0.2	-46	-0.2	-46	-22.6	34
8	-21.3	31	-0.2	-53	-0.2	-53	-21.2	28
9	-20.0	25	-0.2	-60	-0.2	-60	-20.0	22
10	<b>-18.8</b>	<b>19</b>	<b>-0.3</b>	<b>-66</b>	<b>-0.2</b>	<b>-66</b>	<b>-18.8</b>	<b>17</b>
11	<b>-17.7</b>	<b>13</b>	<b>-0.3</b>	<b>-73</b>	<b>-0.3</b>	<b>-73</b>	<b>-17.7</b>	<b>10</b>
12	<b>-16.6</b>	<b>6</b>	<b>-0.3</b>	<b>-79</b>	<b>-0.3</b>	<b>-79</b>	<b>-16.6</b>	<b>4</b>
13	<b>-15.0</b>	<b>1</b>	<b>-0.4</b>	<b>-86</b>	<b>-0.4</b>	<b>-86</b>	<b>-15.0</b>	<b>-1</b>
14	<b>-14.2</b>	<b>-6</b>	<b>-0.4</b>	<b>-93</b>	<b>-0.4</b>	<b>-93</b>	<b>-14.3</b>	<b>-8</b>
15	<b>-13.6</b>	<b>-13</b>	<b>-0.5</b>	<b>-99</b>	<b>-0.5</b>	<b>-99</b>	<b>-13.5</b>	<b>-14</b>
16	<b>-12.9</b>	<b>-19</b>	<b>-0.5</b>	<b>-106</b>	<b>-0.5</b>	<b>-106</b>	<b>-12.8</b>	<b>-21</b>
17	<b>-12.3</b>	<b>-26</b>	<b>-0.5</b>	<b>-113</b>	<b>-0.5</b>	<b>-113</b>	<b>-12.2</b>	<b>-28</b>
18	<b>-11.8</b>	<b>-33</b>	<b>-0.6</b>	<b>-119</b>	<b>-0.6</b>	<b>-119</b>	<b>-11.8</b>	<b>-34</b>
19	<b>-11.4</b>	<b>-40</b>	<b>-0.6</b>	<b>-126</b>	<b>-0.6</b>	<b>-126</b>	<b>-11.3</b>	<b>-40</b>
20	<b>-11.0</b>	<b>-46</b>	<b>-0.7</b>	<b>-132</b>	<b>-0.7</b>	<b>-132</b>	<b>-11.0</b>	<b>-46</b>
21	<b>-10.7</b>	<b>-53</b>	<b>-0.7</b>	<b>-139</b>	<b>-0.7</b>	<b>-139</b>	<b>-10.6</b>	<b>-53</b>
22	<b>-10.5</b>	<b>-59</b>	<b>-0.8</b>	<b>-146</b>	<b>-0.8</b>	<b>-146</b>	<b>-10.4</b>	<b>-60</b>
23	<b>-10.4</b>	<b>-67</b>	<b>-0.8</b>	<b>-152</b>	<b>-0.8</b>	<b>-152</b>	<b>-10.2</b>	<b>-67</b>
24	<b>-10.8</b>	<b>-74</b>	<b>-0.9</b>	<b>-158</b>	<b>-0.9</b>	<b>-158</b>	<b>-10.5</b>	<b>-74</b>
25	<b>-10.9</b>	<b>-76</b>	<b>-0.9</b>	<b>-165</b>	<b>-0.9</b>	<b>-165</b>	<b>-10.8</b>	<b>-76</b>
26	<b>-10.7</b>	<b>-81</b>	<b>-0.9</b>	<b>-172</b>	<b>-0.9</b>	<b>-172</b>	<b>-10.8</b>	<b>-80</b>
27	<b>-11.0</b>	<b>-86</b>	<b>-0.9</b>	<b>-179</b>	<b>-0.9</b>	<b>-179</b>	<b>-10.8</b>	<b>-84</b>
28	-11.1	-90	-1.0	175	-1.0	175	-11.0	-89
29	-11.4	-95	-1.0	168	-0.9	168	-11.2	-93
30	-11.9	-100	-1.0	161	-1.0	161	-11.7	-97
31	-12.5	-104	-1.0	154	-1.0	154	-12.3	-101
32	-13.3	-108	-1.0	147	-1.0	147	-13.0	-103
33	-14.4	-108	-1.1	140	-1.1	140	-13.7	-105
34	-15.1	-104	-1.1	133	-1.1	133	-14.9	-103
35	-16.9	-108	-1.1	125	-1.1	125	-16.3	-104
36	-19.0	-99	-1.1	118	-1.1	118	-18.0	-92
37	-20.3	-79	-1.1	110	-1.1	110	-19.0	-74
38	-20.8	-51	-1.1	102	-1.1	102	-18.9	-51
39	-15.1	-34	-1.3	93	-1.3	93	-14.7	-38
40	-12.5	-33	-1.5	84	-1.5	84	-12.1	-36
41	-10.2	-37	-1.7	76	-1.7	76	-9.9	-37
42	-8.3	-41	-2.1	67	-2.0	67	-8.2	-42
43	-6.9	-47	-2.4	59	-2.4	59	-6.7	-47
44	-5.7	-53	-2.8	51	-2.8	51	-5.6	-52
45	-4.7	-59	-3.3	43	-3.3	43	-4.6	-57

Typical Measured Performance

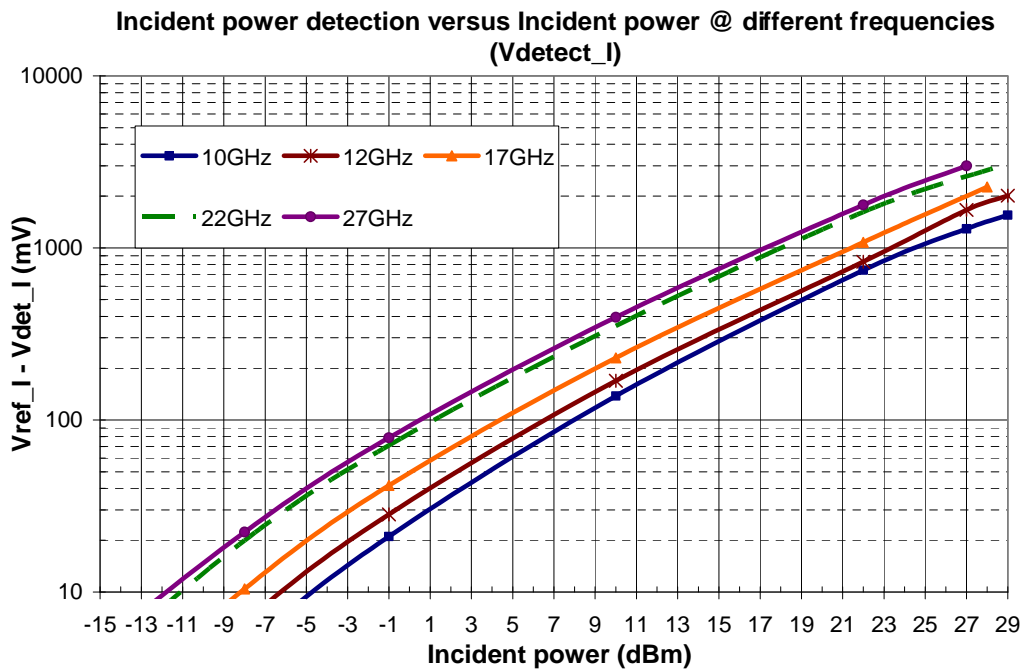
*Preliminary*

On-wafer measurements (without bonding wires at RF ports).

Tamb = +25°C, Vdc = +4.5V (on DC\_I and DC\_R), 100k Ω resistor in parallel on pads Vdet\_I, Vref\_I, Vdet\_R and Vref\_R (see notes, page 8).

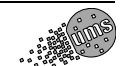
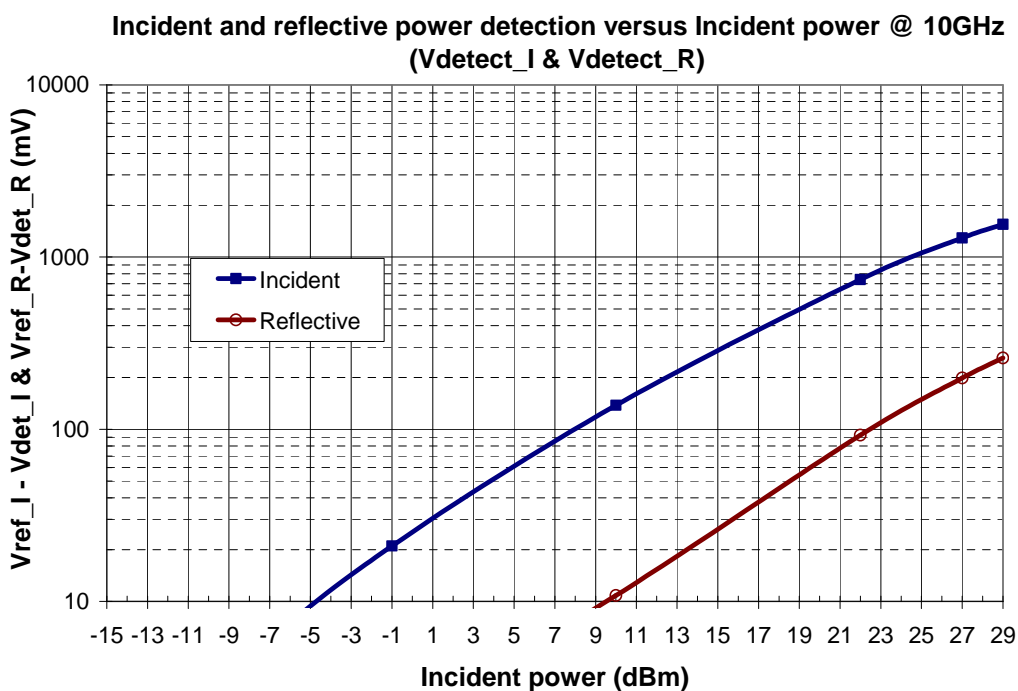


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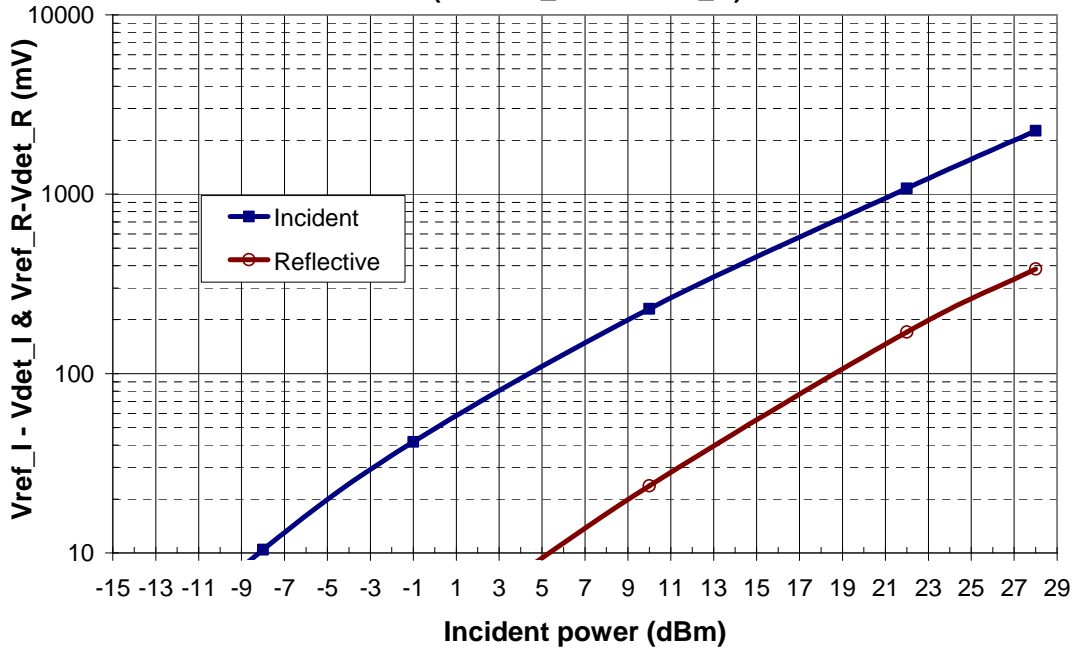
The CHE1260-98F is a bidirectionnal detector using a symmetrical bidirectionnal coupler. Therefore the incident power detection versus incident power is identical to the reflective power detection versus reflected power.

The reflective power detection versus incident power depends on both the coupler directivity and the reflective environment of the chip.

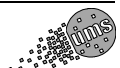
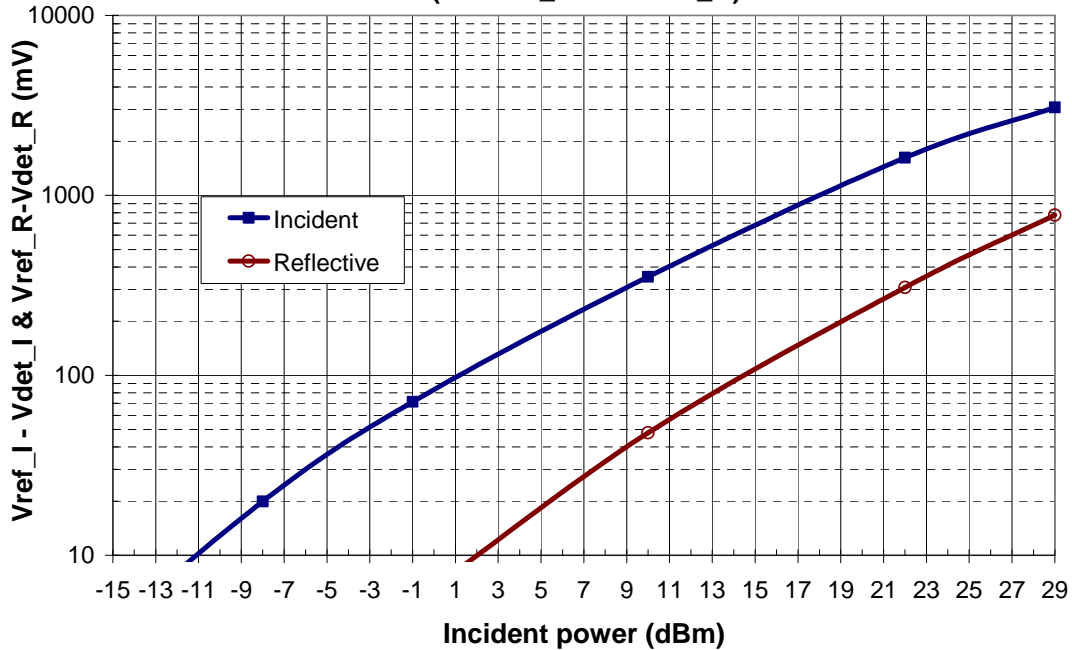


*Preliminary*

Incident and reflective power detection versus Incident power @ 17GHz  
(Vdetect\_I & Vdetect\_R)



Incident and reflective power detection versus Incident power @ 22GHz  
(Vdetect\_I & Vdetect\_R)

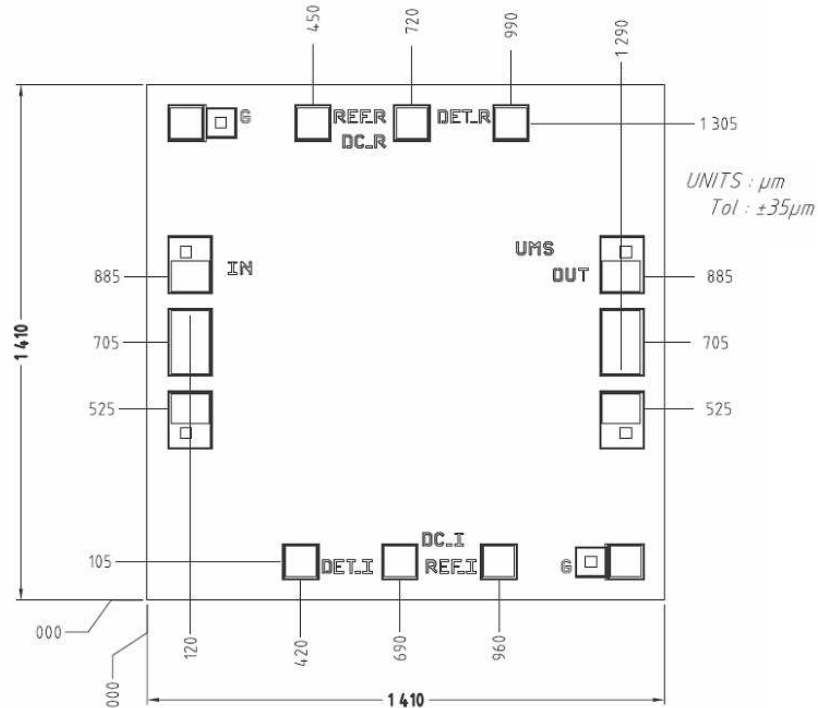


Preliminary

Incident and reflective power detection versus Incident power @ 27GHz  
(Vdetect\_I & Vdetect\_R)

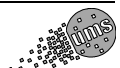


## Chip assembly and Mechanical data:

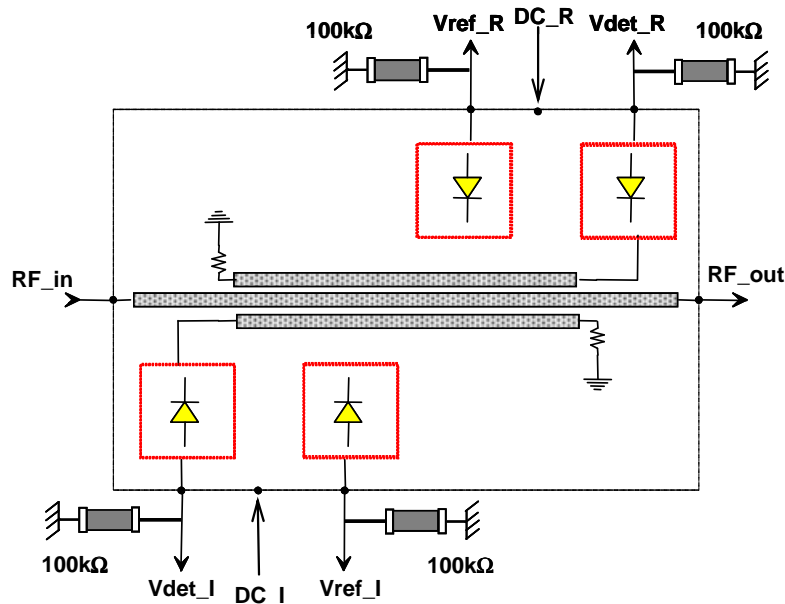


DC Pads Size: 100/100  $\mu\text{m}$ , Chip thickness: 100  $\mu\text{m}$

Note: Supply feed might be capacitively bypassed. 25 $\mu\text{m}$  diameter gold wire is to be preferred.



## Note

*Preliminary*

Recommended external resistors assembly

100kΩ resistors in parallel with Vdet\_I, Vref\_I, Vdet\_R and Vref\_R pads are recommended to provide the best behaviour in the whole operating temperature range.

As the voltage detection is the difference between Vref\_X and Vdet\_X (X= I or R), the external resistor value should be identical on these ports.

For information, a variation of 2% leads around 1mV variation of detected voltage.

ESD protections are implemented on Vdet\_I, Vref\_I, Vdet\_R and Vref\_R accesses.

Due to the BCB coating on the chip, qualification domain implies the chip must be glued.

## Ordering Information

Chip form: CHE1260-98F/00

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